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1. General description

Standard level N-channel MOSFET in D2PAK package qualified to 175C. This product is designed and qualified for use in a wide range of industrial, communications and domestic equipment.

2. Features and benefits

- High efficiency due to low switching and conduction losses
- Suitable for standard level gate drive

3. Applications

- DC-to-DC converters
- Load switching
- Motor control
- Server power supplies

4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions		Min	Тур	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C		-	-	100	V
I _D	drain current	T _{mb} = 25 °C; V _{GS} = 10 V; <u>Fig. 2</u>	[1]	-	-	68	Α
P _{tot}	total power dissipation	T _{mb} = 25 °C; <u>Fig. 1</u>		-	-	170	W
T _j	junction temperature			-55	-	175	°C
Static charact	eristics						
R _{DSon}	drain-source on-state resistance	V _{GS} = 10 V; I _D = 15 A; T _j = 100 °C; Fig. 12; Fig. 13		-	19.4	25	mΩ
		V_{GS} = 10 V; I_D = 15 A; T_j = 25 °C; Fig. 13		-	10.8	13.9	mΩ
Dynamic char	acteristics						
Q_{GD}	gate-drain charge	V _{GS} = 10 V; I _D = 25 A; V _{DS} = 50 V; Fig. 15; Fig. 14		-	17	23.8	nC
Q _{G(tot)}	total gate charge	V _{GS} = 10 V; I _D = 25 A; V _{DS} = 50 V; Fig. 14; Fig. 15		-	59	83	nC





Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Avalanche ruggedness							
E _{DS(AL)S}	non-repetitive drain- source avalanche energy	V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; I_D = 68 A; $V_{sup} \le$ 100 V; unclamped; R_{GS} = 50 Ω		-	-	127	mJ

[1] Continuous current is limited by package

Pinning information

Table 2. **Pinning information**

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate	mb	D I
2	D	drain[1]		
3	S	source		G T A
mb	D	mounting base; connected to drain	1 3	mbb076 S
			D2PAK (SOT404)	

[1] It is not possible to make connection to pin 2.

Ordering information

Table 3. **Ordering information**

Type number	Package					
	Name	Description	Version			
PSMN013-100BS	D2PAK	plastic single-ended surface-mounted package (D2PAK); 3 leads (one lead cropped)	SOT404			

Marking

Table 4. **Marking codes**

Type number	Marking code
PSMN013-100BS	PSMN013-100BS

Limiting values 8.

Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V _{DS}	drain-source voltage	T _j ≥ 25 °C; T _j ≤ 175 °C	-	100	V
V_{DGR}	drain-gate voltage	$T_j \le 175 ^{\circ}\text{C}; T_j \ge 25 ^{\circ}\text{C}; R_{GS} = 20 \text{k}\Omega$	-	100	V

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Symbol	Parameter	Conditions		Min	Max	Unit
V_{GS}	gate-source voltage			-20	20	V
P _{tot}	total power dissipation	T _{mb} = 25 °C; <u>Fig. 1</u>		-	170	W
I _D	drain current	V _{GS} = 10 V; T _{mb} = 100 °C; <u>Fig. 2</u>	[1]	-	47	Α
		V _{GS} = 10 V; T _{mb} = 25 °C; <u>Fig. 2</u>	[1]	-	68	Α
I _{DM}	peak drain current	pulsed; $t_p \le 10 \mu s$; $T_{mb} = 25 °C$; Fig. 3		-	272	Α
T _{stg}	storage temperature			-55	175	°C
Tj	junction temperature			-55	175	°C
$T_{sld(M)}$	peak soldering temperature			-	260	°C
Source-dra	in diode					
Is	source current	T _{mb} = 25 °C	[1]	-	68	Α
I _{SM}	peak source current	pulsed; $t_p \le 10 \ \mu s$; $T_{mb} = 25 \ ^{\circ}C$		-	272	Α
Avalanche	ruggedness	1	-1	'	'	
E _{DS(AL)S}	non-repetitive drain-source avalanche energy	V_{GS} = 10 V; $T_{j(init)}$ = 25 °C; I_D = 68 A; $V_{sup} \le$ 100 V; unclamped; R_{GS} = 50 Ω		-	127	mJ

[1] Continuous current is limited by package

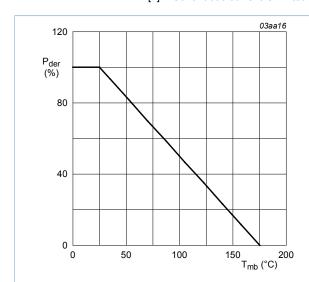


Fig. 1. Normalized total power dissipation as a function of mounting base temperature

$$P_{der} = \frac{P_{tot}}{P_{tot(25^{\circ}C)}} \times 100\%$$

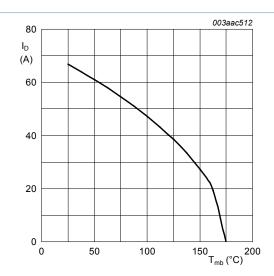


Fig. 2. Continuous drain current as a function of mounting base temperature

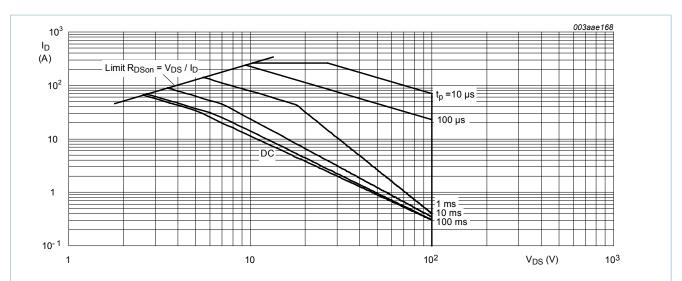


Fig. 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

 T_{mb} = 25 °C; I_{DM} is a single pulse

9. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base	Fig. 4	_	0.5	0.9	K/W
R _{th(j-a)}	thermal resistance from junction to ambient	minimum footprint; mounted on a printed-circuit board	-	50	-	K/W

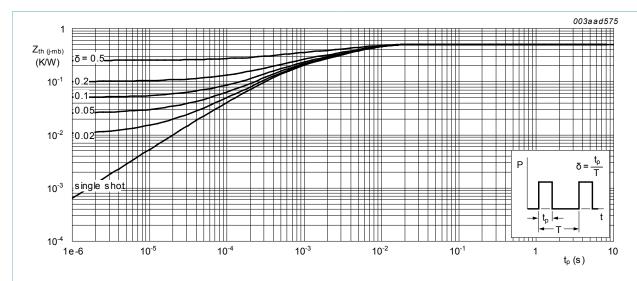


Fig. 4. Transient thermal impedance from junction to mounting base as a function of pulse duration; typical values

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10. Characteristics

Table 7. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static chara	cteristics					
V _{(BR)DSS}	drain-source	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = -55 ^{\circ}\text{C}$	90	-	-	V
	breakdown voltage	$I_D = 0.25 \text{ mA}; V_{GS} = 0 \text{ V}; T_j = 25 ^{\circ}\text{C}$	100	-	-	V
V _{GS(th)}	gate-source threshold voltage	$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = 175 \text{ °C};$ Fig. 10	1	-	-	V
		I _D = 1 mA; V _{DS} = V _{GS} ; T _j = 25 °C; Fig. 10; Fig. 11	2	3	4	V
		$I_D = 1 \text{ mA}; V_{DS} = V_{GS}; T_j = -55 \text{ °C};$ Fig. 10	-	-	4.6	V
I _{DSS}	drain leakage current	V _{DS} = 100 V; V _{GS} = 0 V; T _j = 125 °C	-	-	100	μA
		V _{DS} = 100 V; V _{GS} = 0 V; T _j = 25 °C	-	0.06	2	μA
I _{GSS} gate leakage current	gate leakage current	V _{GS} = 20 V; V _{DS} = 0 V; T _j = 25 °C	-	10	100	nA
		V _{GS} = -20 V; V _{DS} = 0 V; T _j = 25 °C	-	10	100	nA
200	drain-source on-state resistance	V _{GS} = 10 V; I _D = 15 A; T _j = 100 °C; Fig. 12; Fig. 13	-	19.4	25	mΩ
		V _{GS} = 10 V; I _D = 15 A; T _j = 175 °C; Fig. 12; Fig. 13	-	29.5	38.9	mΩ
		V_{GS} = 10 V; I_{D} = 15 A; T_{j} = 25 °C; Fig. 13	-	10.8	13.9	mΩ
R_G	gate resistance	f = 1 MHz	0.5	1	2	Ω
Dynamic ch	aracteristics		l l			
Q _{G(tot)}	total gate charge	I _D = 25 A; V _{DS} = 50 V; V _{GS} = 10 V; Fig. 14; Fig. 15	-	59	83	nC
		I _D = 0 A; V _{DS} = 0 V; V _{GS} = 10 V	-	47.6	66.7	nC
Q_{GS}	gate-source charge	I _D = 25 A; V _{DS} = 50 V; V _{GS} = 10 V; Fig. 14; Fig. 15	-	13.8	19.4	nC
Q _{GS(th)}	pre-threshold gate- source charge	I _D = 25 A; V _{DS} = 50 V; V _{GS} = 10 V; Fig. 15; Fig. 14	-	9.2	-	nC
Q _{GS(th-pl)}	post-threshold gate- source charge		-	4.6	-	nC
Q_{GD}	gate-drain charge		-	17	23.8	nC
$V_{GS(pl)}$	gate-source plateau voltage	V _{DS} = 50 V; <u>Fig. 15</u> ; <u>Fig. 14</u>	-	4.4	-	V
C _{iss}	input capacitance	V _{DS} = 50 V; V _{GS} = 0 V; f = 1 MHz;	-	3195	4315	pF
C _{oss}	output capacitance	T _j = 25 °C; <u>Fig. 16</u>	-	221	300	pF

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Symbol	Parameter	Conditions		Min	Тур	Max	Unit
C _{rss}	reverse transfer capacitance			-	136	191	pF
t _{d(on)}	turn-on delay time	V_{DS} = 50 V; R_{L} = 2 Ω ; V_{GS} = 10 V; $R_{G(ext)}$ = 4.7 Ω ; T_{j} = 25 °C		-	20.7	31.1	ns
t _r	rise time			-	25	37.5	ns
t _{d(off)}	turn-off delay time			-	52.5	78.8	ns
t _f	fall time	1		-	24	36	ns
Source-dra	nin diode						
V _{SD}	source-drain voltage	$I_S = 15 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}; Fig. 17$		-	0.85	1.2	V
t _{rr}	reverse recovery time	I_S = 25 A; dI_S/dt = 100 A/ μ s; V_{GS} = 0 V; V_{DS} = 50 V		-	52	68	ns
Q _r	recovered charge			-	109	142	nC

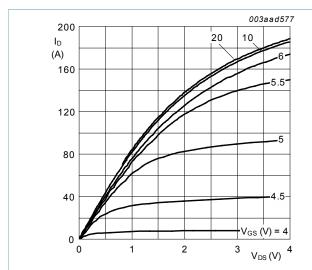


Fig. 5. Output characteristics: drain current as a function of drain-source voltage; typical values



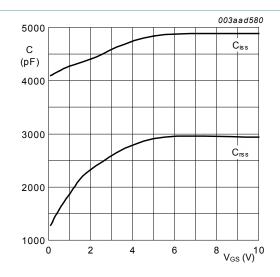


Fig. 6. Input and reverse transfer capacitances as a function of gate-source voltage; typical values

$$V_{DS} = 0V; f = 1MHz$$

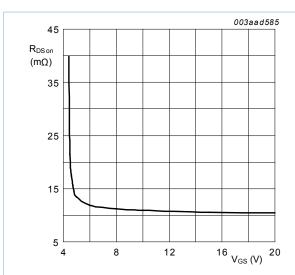


Fig. 7. Drain-source on-state resistance as a function of gate-source voltage; typical values

$$T_j = 25 \,^{\circ}C$$

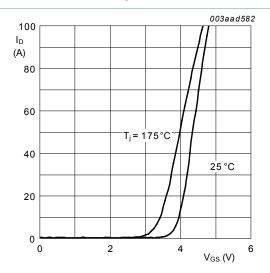


Fig. 9. Transfer characteristics: drain current as a function of gate-source voltage; typical values

$$V_{DS} > I_D \times R_{DSon}$$

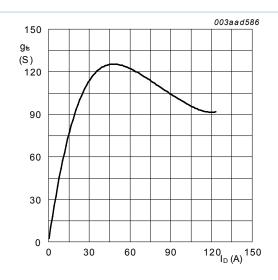


Fig. 8. Forward transconductance as a function of drain current; typical values

$$T_j=25\,^{\circ}C; V_{DS}=15\,V$$

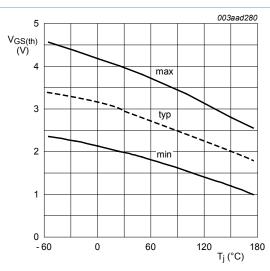


Fig. 10. Gate-source threshold voltage as a function of junction temperature

$$I_D = 1 \text{ mA}; V_{DS} = V_{GS}$$

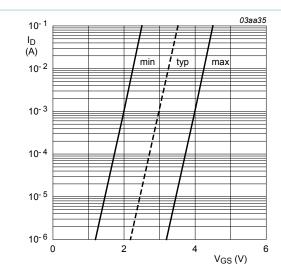


Fig. 11. Sub-threshold drain current as a function of gate-source voltage

$$T_j = 25 \,^{\circ}C; V_{DS} = 5V$$

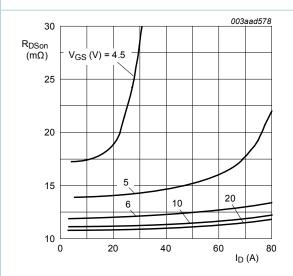


Fig. 13. Drain-source on-state resistance as a function of drain current; typical values

$$T_j = 25 \,^{\circ}C$$

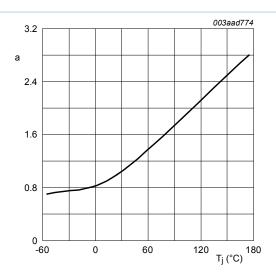


Fig. 12. Normalized drain-source on-state resistance factor as a function of junction temperature

$$a = \frac{R_{DSon}}{R_{DSon(25 \, ^{\circ}\text{C})}}$$

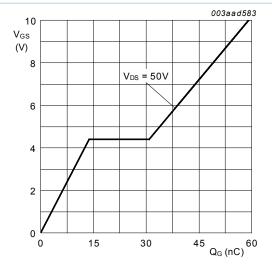


Fig. 14. Gate-source voltage as a function of gate charge; typical values

$$T_j = 25\,^{\circ}C; I_D = 25A$$

NXP Semiconductors PSMN013-100BS

N-channel 100V 13.9m Ω standard level MOSFET in D2PAK

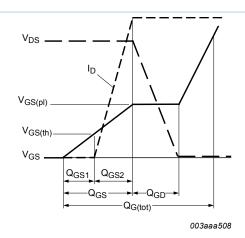


Fig. 15. Gate charge waveform definitions

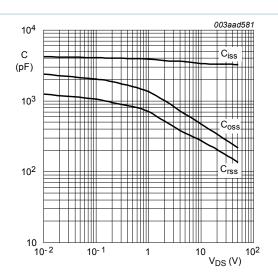


Fig. 16. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

$$V_{GS} = 0V; f = 1MHz$$

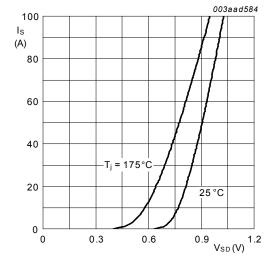
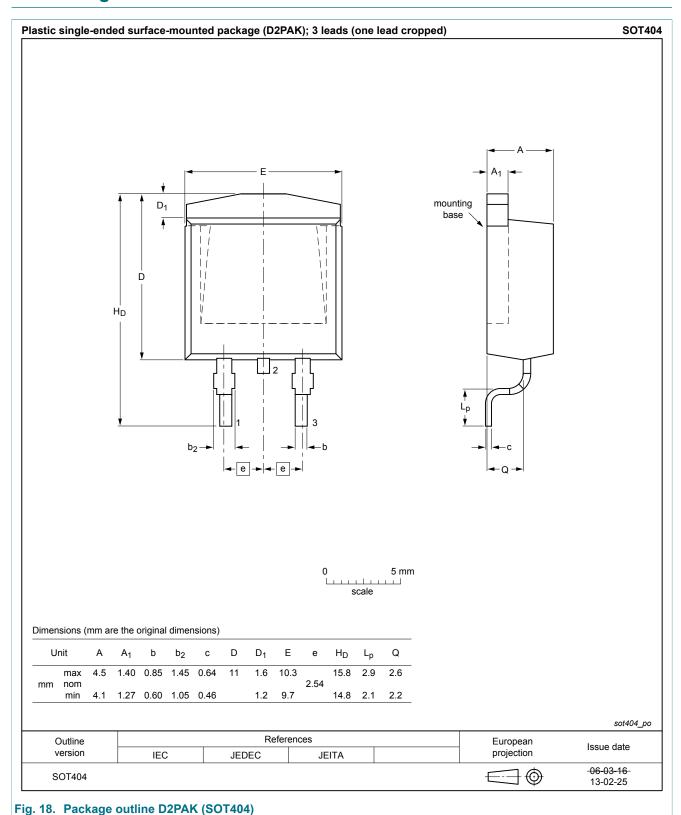


Fig. 17. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values

$$V_{GS} = 0 V$$

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11. Package outline



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12. Legal information

12.1 Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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